

Portable Surface Roughness Tester SURFTEST SJ-410 Series

Bulletin No. 2080



Portable surface roughness tester evolution

Rich choice of options provide easier, smoother and more accurate measurements

Mitutoyo

Portable surface roughness tester evolves!

The large touch-screen, color-graphic LCD ensures both intuitive control and advanced operability

Enhanced power for making measurements on site

Color-graphic LCD

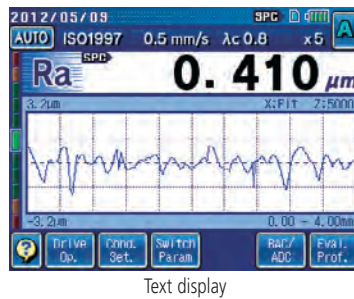
The color-graphic LCD with excellent visibility displays calculated results and assessed profiles even clearer. This is really useful for checking results without printing them out.

Backlight provided

A backlight improves usability in dim testing environments.

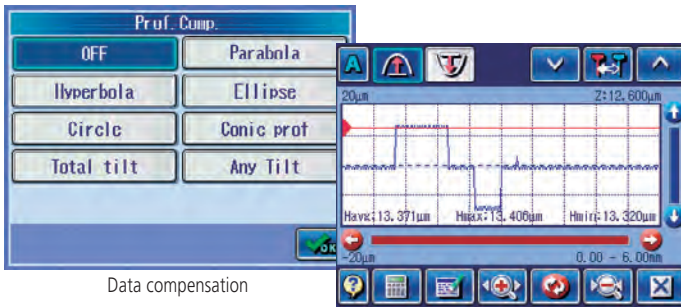
Touch screen for easier operations

The screen display can be switched between icon display and text display. Successfully combining operability with utility and usability.



Easy to use and highly functional

This portable surface roughness tester is equipped with analysis functionality rivaling that of benchtop surface roughness testers.



Applicable standards

Complies with many industry standards

The SurfTest SJ-410 complies with the following standards: JIS (JIS-B0601-2001, JIS-B0601-1994, JIS B0601-1982), VDA, ISO-1997, and ANSI.



Multilingual support

The display interface supports 16 languages.



High accuracy measuring

A wide range, high-resolution detector

Measuring range/ resolution
 800μm/0.01μm
 80μm/0.001μm
 8μm/0.0001μm

High straightness drive unit

Straightness/ traverse length
 0.3μm/25mm (SJ-411)
 0.5μm/50mm (SJ-412)



Surftest SJ-410

Interfaces

A variety of interfaces supplied as standard

The external device interfaces that come as standard include USB, RS-232C, SPC output and footswitch I/F.



Data storage

Memory card (optional) is supported

The measurement conditions and data can be stored in a memory card (optional) and recalled as required. This enables batch analysis and printout of data after on-site measurement.

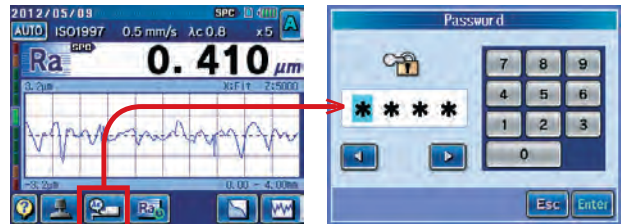


- **Measurement condition**
Internal memory: 10 sets
Memory card: 500 sets
- **Measurement result**
Memory card: 1000 sets

Password protection

Access to functions can be restricted by a password

A pre-registered password can limit use of measurement conditions and other settings to the tester's administrator.



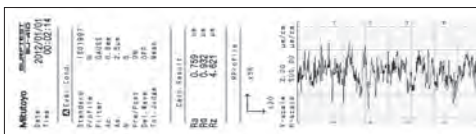
Key-sheet buttons

A sturdy key-sheet-button panel with superior durability in any environment is provided. For repeat measurement of the same work, simply pressing the start switch can complete measurement, analysis and printout.

Printer

High-speed printer prints out measurement results on site

A high-quality, high-speed thermal printer prints out measurement results. It can also print a BAC curve or an ADC curve as well as calculated results and assessed profiles. These results and profiles are printed out in landscape format, just as they appear on the color-graphic LCD.



Carrying case

The unit is easily transported in a dedicated carrying case which includes holders for the accessories as well as the tester itself. (Standard accessory.)



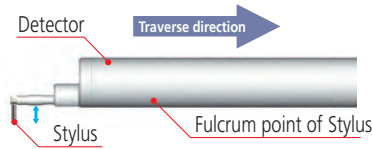
Enhanced measuring functions

Your choice of skidless or skidded measurement

Patent registered in Japan, U.S.A.. Patent pending in Germany

• Skidless measurement

Skidless measurement is where surface features are measured relative to the drive unit reference surface. This measures waviness and finely stepped features accurately, in addition to surface roughness, but range is limited to the stylus travel available. The SJ-410 series supports a variety of surface feature measurements simply by replacing the stylus.



Measuring example of stepped features: Skidless

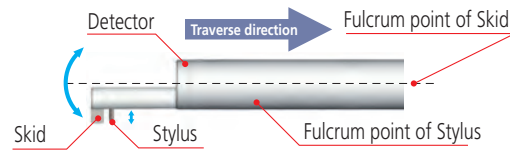


Measured profile



• Skidded measurement

In skidded measurements, surface features are measured with reference to a skid following close behind the stylus. This cannot measure waviness and stepped features exactly but the range of movement within which measurement can be made is greater because the skid tracks the workpiece surface contour.



Measuring example of stepped features: Skidded



Measured profile

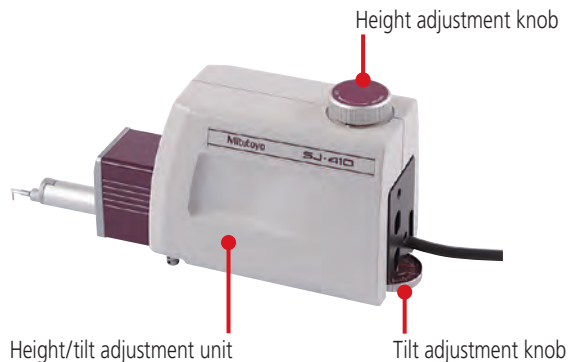


Powerful support for leveling

Patent registered in Japan, U.S.A.. Patent pending in Germany

The height/tilt adjustment unit comes as standard for leveling the drive unit prior to making skidless measurements and, supported by guidance from the unique D.A.T. function, makes it easy to achieve highly accurate alignment.

• Height/tilt adjustment unit (Standard accessory)

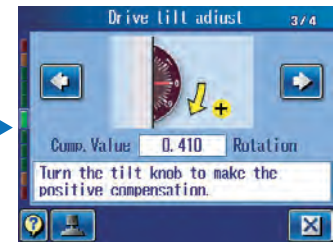


Height/tilt adjustment unit

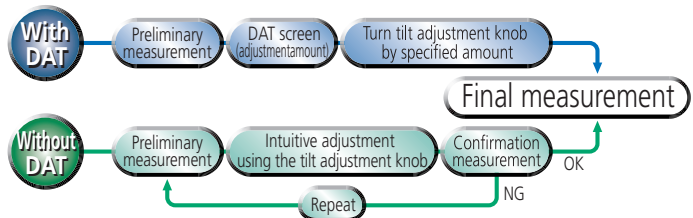
Tilt adjustment knob



Preliminary measurement



Amount of tilt adjustment

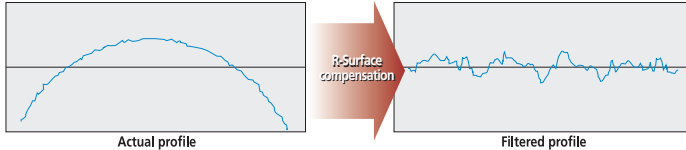


When the SJ-410 Series detector is mounted on the manual column stand*¹ for measurement, it can be combined with any of the optional products for easier leveling: leveling table*¹, 3-axis alignment table*¹ or tilt adjustment unit*¹.

*1: For details about optional products, see P6-7.

More measuring functions than expected from a compact tester

Usually, a spherical or cylindrical surface (R-surface) cannot be evaluated, but, by removing the radius with a filter, R-surface data is processed as if taken from a flat surface.

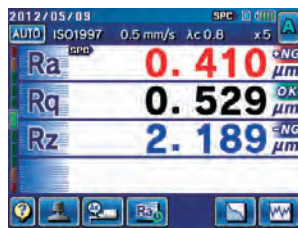


Recalculating

Previously measured data can be recalculated for use in other evaluations by changing the current standard, assessed profile and roughness parameters.

GO/NG judgement function

An "OK/NG" judgment symbol is displayed when limits are set for the roughness parameter. In case of "NG," the calculated result is highlighted. The calculated result can also be printed out.



| Calc. Result | | |
|--------------|----------|----|
| Ra | ↑ 1.103 | μm |
| Rq | OK 1.427 | μm |
| Rz | ↓ 7.259 | μm |

The "OK" symbol means the measurement is within the limits set; "NG" means it is not, in which case an arrow points to either the upper or lower limit in the printout.

Assessing a single measurement result under two different evaluation conditions

A single measurement enables simultaneous analysis under two different evaluation conditions. A single measurement allows calculation of parameters and analysis of assessed profiles without the need for recalculation after saving data, contributing to higher work efficiency.



Arbitrary sampling length setting

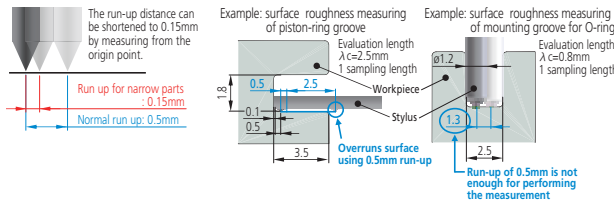
This function allows a sampling length to be arbitrarily set in 0.01mm increments (SJ-411: 0.1mm to 25mm, SJ-412: 0.1mm to 50mm).

It also allows the SJ-410 series to make both narrow and wide range measurements.

Narrow space measuring function Patent pending in Japan

Surface roughness measurement requires a run-up distance before starting the measurement (or retrieving data). When the SJ-410 Series measures, its run-up distance is normally set to 0.5mm. This distance, however, can be shortened to 0.15mm using the narrow part measurement function (starting from the origin point of the drive unit). The function extends the possibility of measurement of narrow locations such as grooves in piston ring / O-ring mounts.

• Narrow space measuring Typical applications

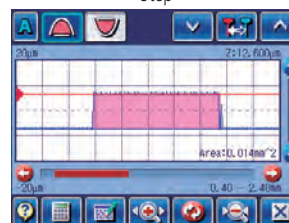
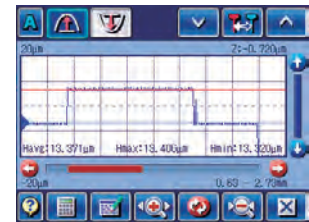


Real sampling

This function samples stylus displacement for a specified time without engaging detector traverse, which enables use as a simplified vibration meter or displacement gage incorporated in another system.

Simple contour analysis function

Point group data collected for surface roughness evaluation is used to perform simplified contour analysis (step, step height, area and coordinate variation). It assesses minute forms that cannot be assessed by a contour measurer.



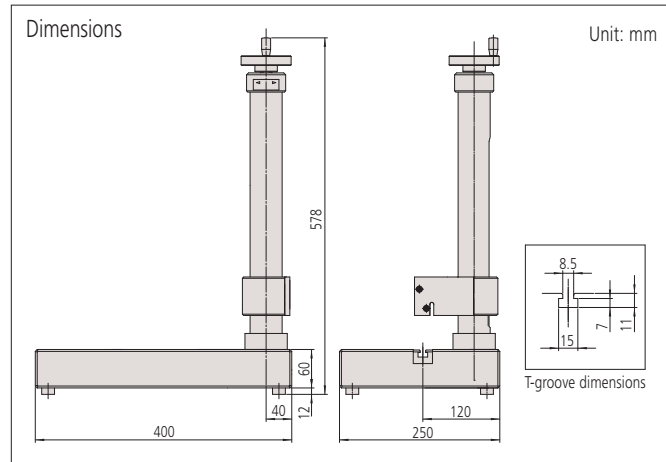
Optional Accessories

Simple column stand

Can be adjusted to match the height of the item to be measured.

No.178-039

Vertical adjustment range: 250mm
Dimensions: 400x250x578mm
Mass: 20kg



Options for simple column stand

Three new optional products are available to be attached to the manual column stand (No.178-039). You can choose the unit that suits your application. Or, you can also use the three products in any combination. Using the optional units makes SJ-411/412 more convenient and easier to use to ensure accurate measurements.

•Auto-set unit (178-010)*

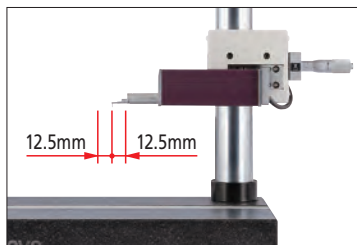
This unit enables the vertical (Z axis) direction to be positioned automatically (auto-set function).

A single button operation completes a series of operations from measurement, saving and auto-return (saving and auto-return can be switched on and off by operating the drive unit).



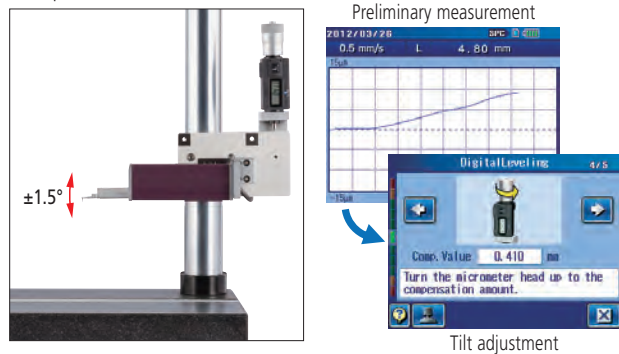
•X-axis adjustment unit (178-020)*

This unit helps fine-tune the horizontal (X axis) direction.

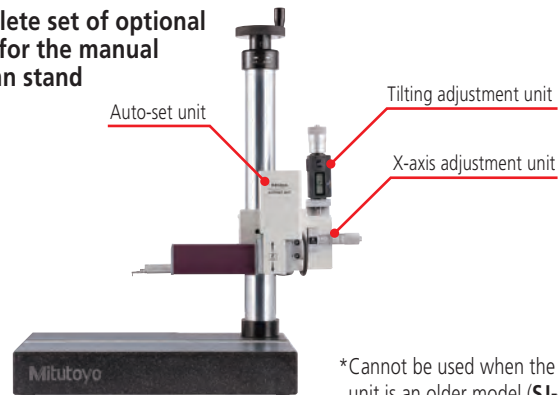


•Tilting adjustment unit (178-030)*

This unit is used for aligning the workpiece surface with the detector reference plane. It supports the DAT function to make the leveling of workpiece surfaces easier.



Complete set of optional units for the manual column stand

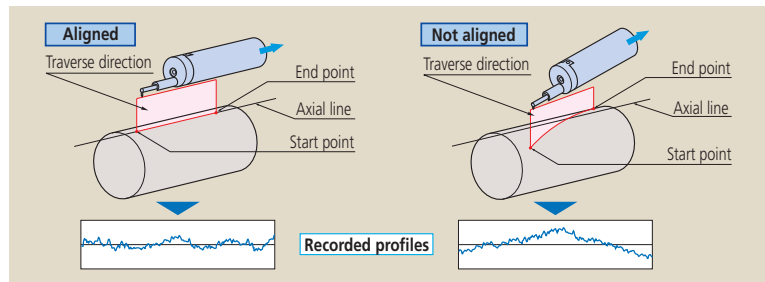


*Cannot be used when the tester's main unit is an older model (SJ-401/402).

3-axis Adjustment Table: 178-047

Patent registered in Japan, U.S.A... Patent pending in Germany

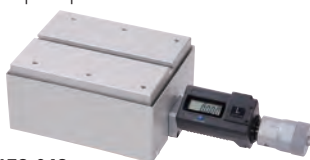
This table helps make the alignment adjustments required when measuring cylindrical surfaces. The corrections for the pitch angle and the swivel angle are determined from a preliminary measurement and the Digimatic micrometers are adjusted accordingly. A flat-surfaced workpiece can also be leveled with this table.



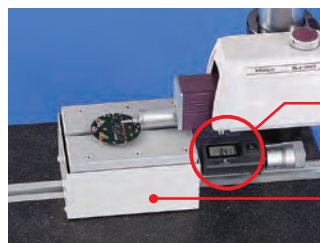
DAT Function for the optional leveling table

Patent registered in Japan, U.S.A... Patent pending in Germany

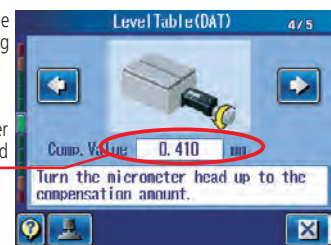
The levelling table can be used to align the surface to be tested with the detector reference plane. The operator is guided through the procedure by screen prompts.



No. 178-048
Inclination adjustment angle: $\pm 1.5^\circ$
Table dimensions: 130x100mm
Maximum load: 15kg

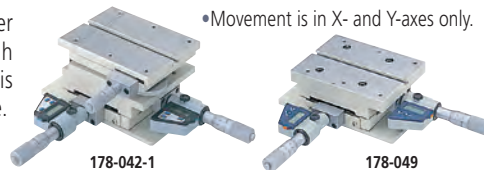


DAT screen guides the user when leveling
Digimatic micrometer head
Amount of micrometer head adjustment required
Leveling table (DAT) (Option)



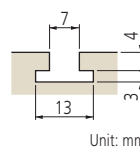
XY leveling tables

The tester includes X- and Y-axes micrometer heads. This makes axis alignment much easier because the tilt adjustment center is the same as the rotation center of the table.
(Code No. **178-042-1/178-043-1**)



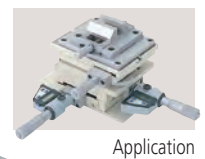
| Order No. | 178-042-1(mm) 178-052-1(inch) *with digital heads | 178-043-1(mm) 178-053-1(inch) *with analog heads | 178-049(mm) 178-058(inch/mm) *with digital heads |
|------------------------------|---|--|--|
| Table dimensions | 130x100mm | | |
| Maximum load | 15kg | | |
| Inclination adjustment angle | $\pm 1.5^\circ$ | — | — |
| Swiveling angle | $\pm 3^\circ$ | — | — |
| XY-axis travel range | ± 12.5 mm | ± 12.5 mm | ± 12.5 mm |
| Resolution | 0.001mm | 0.01mm | 0.001mm |
| Dimensions (WxDxH) | 262x233x83mm | 220x189x83mm | 262x233x55mm |
| Mass | 6.3kg | 6kg | 5kg |

*T-groove dimensions



Precision vise

• Fits on the stand.



| Order No. | 178-019 |
|-----------------|--------------|
| Clamping method | Sliding jaws |
| Jaw opening | 36mm |
| Jaw width | 44mm |
| Jaw depth | 16mm |
| Height | 38mm |

Cylinder attachment

This block can be positioned on top of cylindrical objects to perform measurements.

No. 12AAB358
Diameter: $\varnothing 15\text{--}60$ mm

Configuration:

- Cylindrical measurement block
- Auxiliary block
- Clamp

*Drive unit not included.



Reference step specimen

Used to calibrate detector sensitivity.

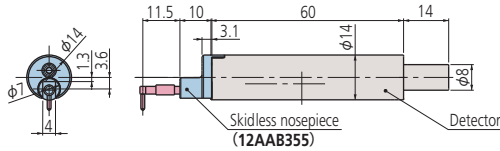
No. 178-611
Step nominal values: $2\mu\text{m}/10\mu\text{m}$



Optional Accessories: Detectors / Styli

Detectors

Unit: mm



| Order No. | Measuring force | |
|-----------|-----------------|--|
| 178-396-2 | 0.75mN | ISO-1997 and JIS-2001 compliant detectors |
| 178-397-2 | 4mN | Detectors that comply with previous standards, for general use, etc. |

Extension rods

- 12AAG202 Extension rod 50mm
- 12AAG203 Extension rod 100mm

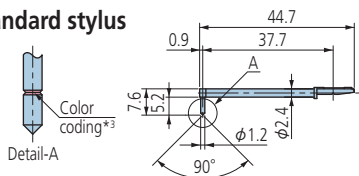


* No more than one extension rod can be connected.

Styli

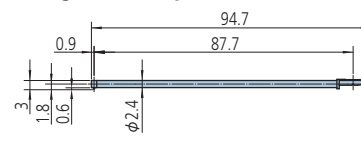
Unit: mm

Standard stylus



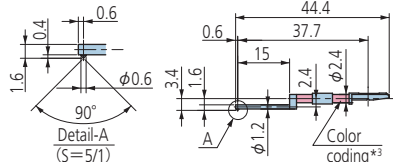
- 12AAE882 (1μm) *1
 - 12AAE924 (1μm)
 - 12AAC731 (2μm) *1
 - 12AAB403 (5μm)
 - 12AAB415 (10μm)
 - 12AAE883 (250μm) *4
- (): Tip radius

Double-length for deep hole *2



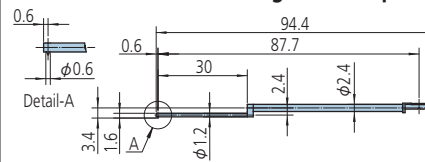
- 12AAE898 (2μm) *1
 - 12AAE914 (5μm)
- (): Tip radius

For small hole



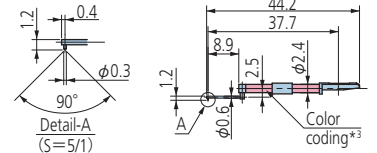
- 12AAC732 (2μm) *1
 - 12AAB404 (5μm)
 - 12AAB416 (10μm)
- (): Tip radius

For small hole / Double-length for deep hole *2



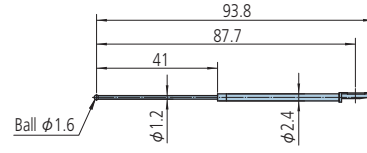
- 12AAE892 (2μm) *1
 - 12AAE908 (5μm)
- (): Tip radius

For extra-small hole



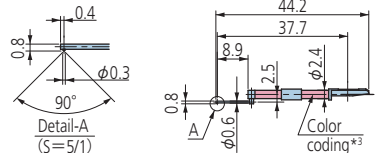
- 12AAC733 (2μm) *1
 - 12AAB405 (5μm)
 - 12AAB417 (10μm)
- (): Tip radius

For small hole *2 *4



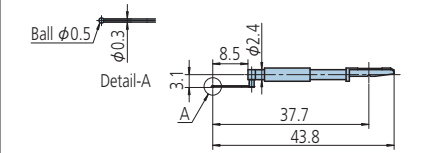
- 12AAE884 (φ1.6mm)
- (): Tip radius

For ultra-small hole



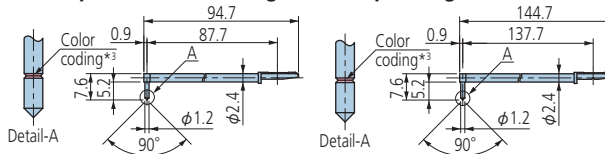
- 12AAC734 (2μm) *1
 - 12AAB406 (5μm)
 - 12AAB418 (10μm)
- (): Tip radius

For ultra-small hole *4



- 12AAJ662 (φ0.5mm)
- (): Tip radius

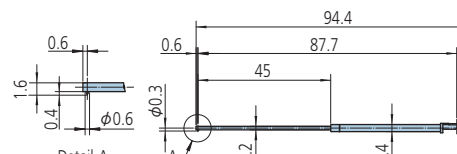
For deep hole (double-length and triple-length) *2



- 2X stylus
- 12AAC740 (2μm) *1
 - 12AAB413 (5μm)
 - 12AAB425 (10μm)
- (): Tip radius

- 3X stylus
- 12AAC741 (2μm) *1
 - 12AAB414 (5μm)
 - 12AAB426 (10μm)
- (): Tip radius

For small slotted hole *2



- 12AAE938 (2μm) *1
 - 12AAE940 (5μm)
- (): Tip radius

*1: Tip angle 60°

*2: For downward-facing measurement only.

*3:

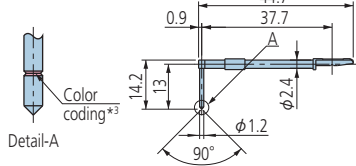
| Tip radius | 1μm | 2μm | 5μm | 10μm | 250μm |
|--------------|-------|-------|----------|--------|-------------------|
| Color coding | White | Black | No color | Yellow | No notch or color |

*4: Used for calibration, a standard step gauge (No.178-611, option) is also required

Styli

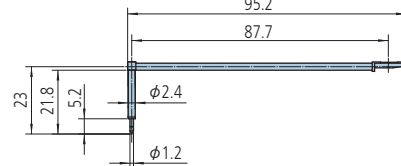
Unit: mm

For deep groove (10mm)



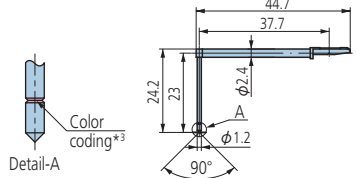
12AAC735 (2μm) *1
12AAB409 (5μm)
12AAB421 (10μm)
(): Tip radius

For deep groove *2 (20mm)



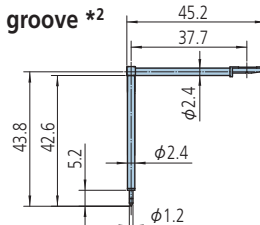
12AAE893 (2μm) *1
12AAE909 (5μm)
(): Tip radius

For deep groove *2 (20mm)



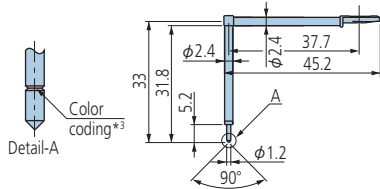
12AAC736 (2μm) *1
12AAB408 (5μm)
12AAB420 (10μm)
(): Tip radius

For deep groove *2 (40mm)



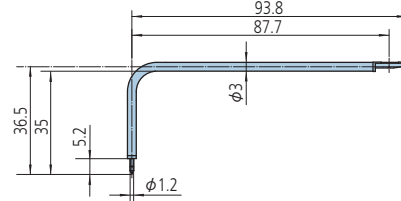
12AAE895 (2μm) *1
12AAE911 (5μm)
(): Tip radius

For deep groove *2 (30mm)



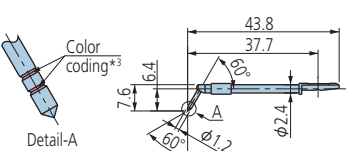
12AAC737 (2μm) *1
12AAB407 (5μm)
12AAB419 (10μm)
(): Tip radius

For deep groove (30mm) / Double-length for deep hole *2



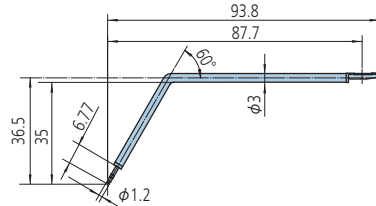
12AAE894 (2μm) *1
12AAE910 (5μm)
(): Tip radius

For gear tooth



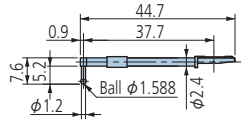
12AAB339 (2μm) *1
12AAB410 (5μm)
12AAB422 (10μm)
(): Tip radius

For gear tooth / Double-length for deep hole *2



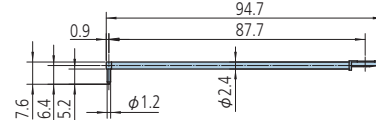
12AAE896 (2μm) *1
12AAE912 (5μm) *1
(): Tip radius

For rolling circle waviness surface *4



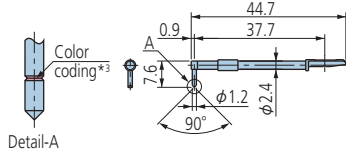
12AAB338 (ϕ1.588)
(): Tip radius

For rolling circle waviness / Double-length for deep hole *2 *4



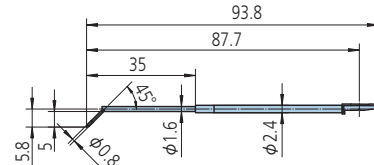
12AAE886 (250μm)
(): Tip radius

For knife-edge *4



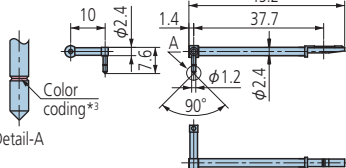
12AAC738 (2μm) *1
12AAB411 (5μm)
12AAB423 (10μm)
(): Tip radius

For corner hole / Double-length for deep hole *2



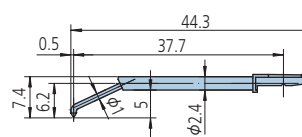
12AAE897 (2μm) *1
12AAE913 (5μm) *2
(): Tip radius

For eccentric arm *2



12AAC739 (2μm) *1
12AAB412 (5μm)
12AAB424 (10μm)
(): Tip radius

For hole bottom



12AAE899 (2μm) *1
12AAE915 (5μm)
(): Tip radius

*1: Tip angle 60°

*2: For downward-facing measurement only.

*3: Customized special interchangeable styli are available on request. Please contact any Mitutoyo office for more information.

*3:

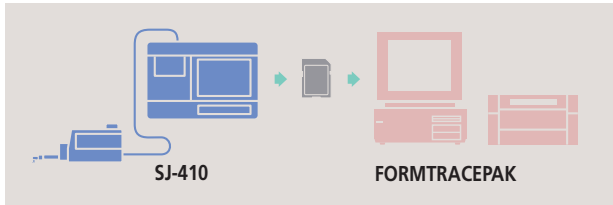
| | | | |
|--------------|-------|----------|--------|
| Tip radius | 2μm | 5μm | 10μm |
| Color coding | Black | No color | Yellow |

*4: Used for calibration, a standard step gauge (No.178-611, option) is also required

Optional Accessories: For External Output

Contour / Roughness analysis software FORMTRACEPAK

More advanced analysis can be performed by loading SJ-410 series measurement data to software program FORMTRACEPAK via a memory card (option) for processing back at base.



Digimatic mini processor DP-1VR

By connecting this printer to the Surfctest SJ-410's digimatic output, you can print calculation results, perform a variety of statistical analyses, draw a histogram or D chart, and also perform complicated operations for X-R control charts.

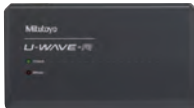


No.264-504 -5A

SJ-410 → DP-1VR Connecting cable
1m: No.936937
2m: No.965014

Measurement Data Wireless Communication System U-WAVE

This unit allows you to remotely load Surfctest SJ-410 calculation results (SPC output) into commercial spreadsheet software on a PC. You can essentially use a one-touch operation to enter the calculation results (values) into the cells in the spreadsheet software.



U-WAVE-R
(Connects to the PC)
No.02AZD810D



U-WAVE-T *
(Connects to the SJ-410)
No.02AZD880D

*Requires the optional Surfctest SJ-410 connection cable.

No.02AZD790D

Simplified communication program for SURFTEST SJ series

The Surfctest SJ-410 series has a USB interface, enabling data to be transferred to a spreadsheet or other software. We also provide a program that lets you create inspection record tables using a Microsoft Excel* macro.

This program can be downloaded free of charge from the Mitutoyo website.
<http://www.mitutoyo.co.jp>

Required environment*

- OS: Windows XP-SP3
Windows Vista
Windows 7
- Spreadsheet software: Microsoft Excel 2002
Microsoft Excel 2003
Microsoft Excel 2007
Microsoft Excel 2010

*Windows OS and Microsoft Excel are products of Microsoft Corporation.

The optional USB cable is also required.

- USB cable for SJ-410 series No.12AAD510

Calculation results input unit INPUT TOOL

This unit allows you to load Surfctest SJ-410 calculation results (SPC output) into commercial spreadsheet software on a PC via a USB connector. You can essentially use a one-touch operation to enter the calculation results (values) into the cells in the spreadsheet software.



USB-ITN-D
No.06ADV380D



USB keyboard signal conversion type* IT-012U
No.264-012-10

*Requires the optional Surfctest SJ-410 connection cable.

1m: No.936937
2m: No.965014

Optional accessories, consumables, and others for SJ-410

- Printer paper (5 rolls) No.270732
- Durable printer paper (5 rolls) No.12AAA876
- Touch-screen protector sheet (10 sheets) No.12AAN040
- Memory card (2GB) * No.12AAL069
- Connecting cable (for RS-232C) No.12AAA882

*micro SD card (with a conversion adapter to SD card)

Specifications

| Model No. | SJ-411 | | SJ-412 | | |
|-----------------------------|---|--|--|---|---|
| | inch/mm | 178-581-01A | 178-581-02A | 178-583-01A | 178-583-02A |
| Measuring range | X axis | 25mm (1inch) | | 50mm (2inch) | |
| | Z1 axis (detector unit) | 800 μ m, 80 μ m, 8 μ m *Up to 2,400 μ m with an optional stylus | | | |
| Detector | Measuring principle | Differential inductance | | | |
| | Resolution | 0.01 μ m (800 μ m range) / 0.001 μ m (80 μ m range) / 0.0001 μ m (8 μ m range) 0.4 μ inch (32000 μ inch) / 0.04 μ inch (3200 μ inch) / 0.004 μ inch (320 μ inch) | | | |
| | Stylus tip | 60°/2 μ m (80 μ inch) | 90°/5 μ m (200 μ inch) | 60°/2 μ m (80 μ inch) | 90°/5 μ m (200 μ inch) |
| | Measuring force | 0.75mN | 4mN | 0.75mN | 4mN |
| | Radius of skid curvature | R40 mm (R1.57") | | | |
| | Measuring method | Skidded measurement / skidless measurement | | | |
| Drive unit: X-axis | Measuring speed | 0.05, 0.1, 0.2, 0.5, 1.0mm/s (0.002, 0.004, 0.02, 0.04 inch/s) | | | |
| | Drive speed | 0.5, 1, 2, 5mm/s (0.02, 0.04, 0.08, 0.2 inch/s) | | | |
| | Straightness | 0.3 μ m / 25mm (12 μ inch/ 1inch) | | 0.5 μ m / 50mm (20 μ inch/ 2inch) | |
| Height-tilt adjustment unit | Height adjustment | 10mm (0.39inch) | | | |
| | Tilt adjustment | \pm 1.5° | | | |
| Standards | JIS1982 / JIS1994 / JIS2001 / ISO1997 / ANSI / VDA | | | | |
| Parameters | Ra, Rq, Rz, Ry, Rp, Rv, Rt, R3z, Rsk, Rku, Rc, Rpc, RSm, Rmax*1, Rz1max*2, S, HSC, RzJIS*3, Rppi, R Δ a, R Δ q, Rlr, Rmr, Rmr(c), R σ c, Rk, Rpk, Rvk, Mr1, Mr2, A1, A2, Vo, λ a, λ q, Lo, Rpm, tp*4, Htp*4, R, Rx, AR, W, AW, Wx, Wte, Possible Customize | | | | |
| Measured profiles | Primary, Roughness, DF, Filtered waviness curve, R-Motif, W-Motif | | | | |
| Graph analysis | BAC and ADC curves | | | | |
| Data compensation | Parabola/ Hyperbola/ Ellipse/ Circle/ Conic/ Tilting, Compensation off | | | | |
| Filter | 2CR, PC75, Gaussian filter | | | | |
| Cut-off length | λ_c | 0.08, 0.25, 0.8, 2.5, 8.0mm | | | |
| | λ_s *5 | 2.5, 8.0, 25mm (100, 320, 1000 μ inch) | | | |
| Sample length | 0.08, 0.25, 0.8, 2.5, 8.0, 25.0mm | | | | |
| Number of sampling lengths | x1, x2, x3, x4, x5, x6, x7, x8, x9, x10, x11, x12, x13, x14, x15, x16, x17, x18, x19, x20 | | | | |
| Arbitrary length | 0.1~25mm | | 0.1~50mm | | |
| | Customization | Desired parameters can be selected for calculation and display | | | |
| Functions | Simple contour analysis function | Step, Step volume, Dimensions, Coordinate difference | | | |
| | DAT function | Helps to adjust leveling during skidless measurement | | | |
| | Real sampling function | Samples stylus displacement for a specified time without engaging detector traverse. | | | |
| | Statistical processing | Static measurement (max. 3 parameters) is possible. Static processing for MAX, MIN, AVERAGE, standard deviation, histogram and pass rate is possible | | | |
| | GO/ NG judgement*6 | Max rule / 16% rule / Average rule / Standard deviation (1 σ , 2 σ , 3 σ) | | | |
| | Storage functions | 10 measuring conditions can be stored in internal memory | | | |
| | Printing function | Measurement conditions / Calculation results / GO / NG judgement result / Calculation results for each sampling length / Measurement curve / BAC / ADC / Environmental setting information | | | |
| | Display languages | Japanese, English, German, French, Italian, Spanish, Portuguese, Korean, Traditional Chinese, Simplified Chinese, Czech, Polish, Hungarian Turkish, Swedish, Dutch | | | |
| | Storage | Internal memory: Measurement condition (10 sets) Memory card (option): 500 measurement condition, 10000 measuring data, 10000 text data, 500 statistic data, 1 backup of machine setting, the last ten traces (Trace 10) | | | |
| | External I/O | USB I/F, Digimatic output, RS-232C I/F, External SW I/F | | | |
| Power supply | Battery | Two-way power supply: battery (rechargeable Ni-MH battery) and AC adapter *Charging time: about 4 hours (may vary due to ambient temperature) *Endurance: about 1500 measurements (differs slightly due to use conditions / environment) | | | |
| | Power consumption | 50W | | | |
| Size (WxDxH) | Display unit | 275x198x109mm (10.83x4.29x7.80inch) | | | |
| | Height adjustment unit | 130.9x63x99mm (5.16x2.48x3.90 inch) | | | |
| | Drive unit | 128x35.8x46.6mm (5.04x1.41x1.83 inch) | 154.5x35.8x46.6mm (6.08x1.41x1.83inch) | | |
| Mass | Display unit | 1.7kg | | | |
| | Height adjustment unit | 0.4kg | | | |
| | Drive unit | 0.6kg | | 0.64kg | |
| Standard accessories | Detector*7, Stylus*8, Roughness specimen 270732 Printing paper 12BAL402 Touch-screen protection sheet | | 12BAG834 Touch pen 12AAN041 Carrying case | | AC adapter, Philips screwdriver, Strap for stylus pen, Operation manual, Quick reference manual, Warranty |

*1: Only for VDA/ANSI/JIS'82 standards.

*2: Only for JIS'97 standard.

*3: Only for JIS'01 standard.

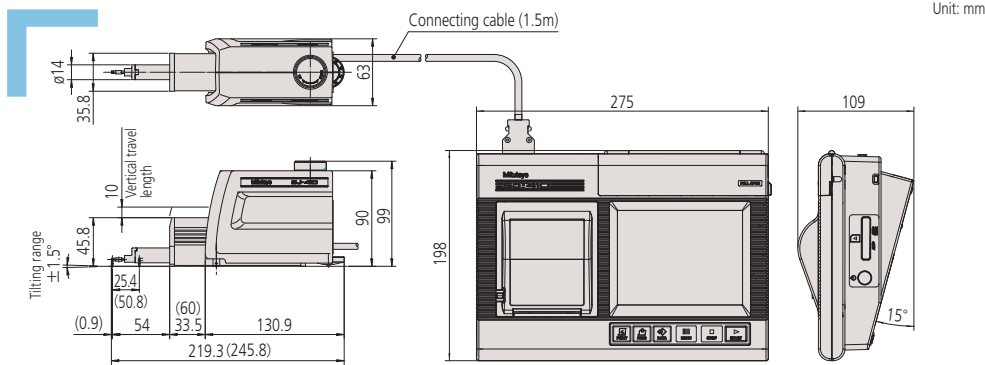
*4: Only for ANSI standard.

*5: λ_s may not be switchable depending on standard selected.

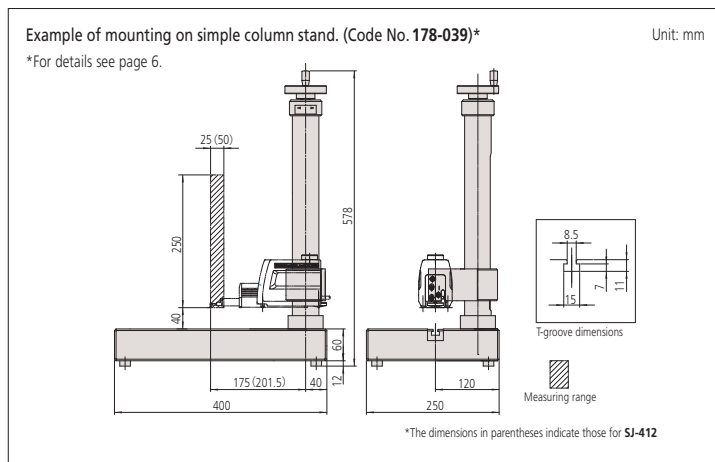
*6: Standard deviation only can be selected in ANSI.16% rule cannot be selected in VDA.

*7: Either **No.178-396-2** or **No.178-397-2** is supplied as a standard accessory depending on the Order No. of the main unit for SJ-410 Series.

*8: The standard stylus (**No.12AAC731** or **No.12AAB403**), which is compatible with the detector supplied, is a standard accessory.



*The dimensions in parentheses indicate those for SJ-412



*The dimensions in parentheses indicate those for SJ-412

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Unit: mm

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- Vision Measuring Systems
- Form Measurement
- Optical Measuring
- Sensor Systems
- Test Equipment and Seismometers
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